

MC3212-VB Datasheet N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (TYP.)			
30	0.016 at V _{GS} = 10 V	9	9 nC			
30	0.019 at V _{GS} = 4.5 V	8	9110			

FEATURES

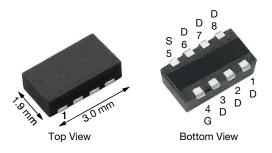
• Trench power MOSFET

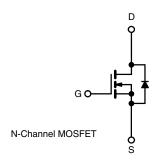
Pb-free

- APPLICATIONSLoad switches
 - Notebook PC









ABSOLUTE MAXIMUM RATING	- ()				
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20	·	
	T _C = 25 °C		9		
Continuous Drain Correct (T. 150 °C)	T _C = 70 °C		6 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	6 a, b, c		
	T _A = 70 °C		6 a, b, c	Α	
Pulsed Drain Current		I _{DM}	30		
Continuous Common Dunio Dindo Commont	T _C = 25 °C		5.2		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.1 b, c		
	T _C = 25 °C		6.3		
Marian and Danier Distriction	T _C = 70 °C	Б.	4	14/	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 b, c	W	
	T _A = 70 °C		1.6 ^{b, c}		
Operating Junction and Storage Temperatur	T _J , T _{stg} -55 to +150		***		
Soldering Recommendations (Peak Tempera		260	°C		

THERMAL RESISTANCE RATINGS								
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT				
Maximum Junction-to-Ambient a, c, d	t ≤ 5 s	R_{thJA}	40	50	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	15	20	C/W			

Notes

- a. Package limited, $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under steady state conditions is 95 °C/W.
- e. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- f. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A	-	31	-	mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-5.1	-	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.2	-	2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zara Cata Valta da Busin Comunat		V _{DS} = 30 V, V _{GS} = 0 V	-	-	1	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C	-	-	5	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	20	-	-	Α
Durin On the On Olete Brainlean 2	5	$V_{GS} = 10 \text{ V}, I_D = 9.1 \text{ A}$	-	0.016	-	Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 8.1 \text{ A}$	ī	0.019	-	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_D = 9.1 \text{ A}$	-	30	-	S
Dynamic ^b				•		
Input Capacitance	C _{iss}		-	1200	-	pF
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	180	-	
Reverse Transfer Capacitance	C _{rss}		-	80	-	
T	Q _g	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 9.1 \text{ A}$	-	19	29	nC
Total Gate Charge			-	9	14	
Gate-Source Charge	Q _{qs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 9.1 \text{ A}$	-	3.5	-	
Gate-Drain Charge	Q_{qd}		-	2.3	-	
Gate Resistance	R _q	f = 1 MHz	-	3	-	Ω
Turn-On Delay Time	t _{d(on)}		-	20	30	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_{L} = 2.1 \Omega$	-	12	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 7.3 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	20	30	
Fall Time	t _f		-	10	15	
Turn-On Delay Time	t _{d(on)}		-	10	15	ns
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 2.1 \Omega$	-	10	15	1
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 7.3 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	20	30	
Fall Time	t _f		-	10	15	
Drain-Source Body Diode Characteristic	s			•		
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	5.2	
Pulse Diode Forward Current	I _{SM}	-	-	-	30	Α
Body Diode Voltage	V _{SD}	I _S = 7.3 A, V _{GS} = 0 V	-	0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}		-	20	40	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	10	20	nC
Reverse Recovery Fall Time	t _a	$I_F = 7.3 \text{ A, dl/dt} = 100 \text{ A/µs, } I_J = 25 \text{ °C}$		11	-	ns
Reverse Recovery Rise Time	t _b			9	_	

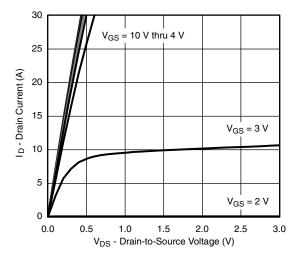
Notes

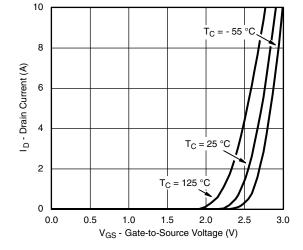
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



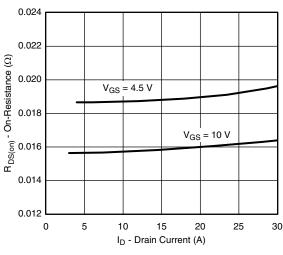
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

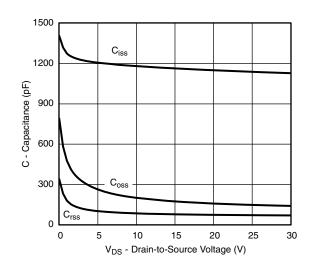




Output Characteristics

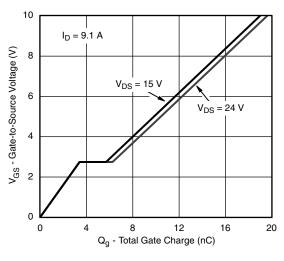
Transfer Characteristics

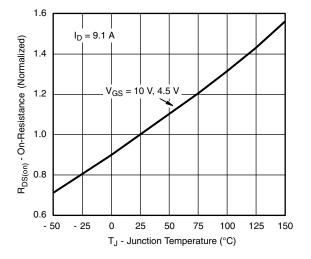




On-Resistance vs. Drain Current

Capacitance





Gate Charge

On-Resistance vs. Junction Temperature



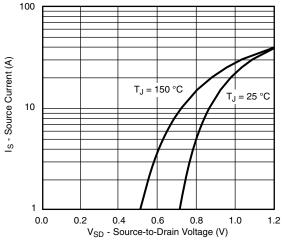
 $T_J = 125~^{\circ}C$

 $T_J = 25 \, ^{\circ}C$

8

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Source-Drain Diode Forward Voltage
On-Resistance vs. Gate-to-Source Voltage

0.05

0.04

0.03

0.02

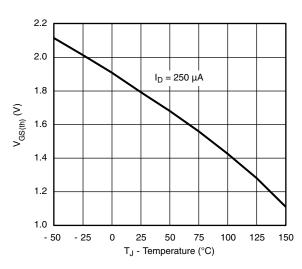
0.01

0 L

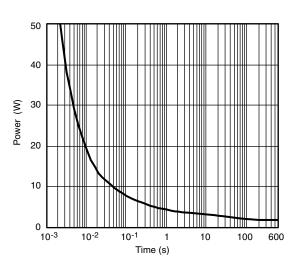
 $R_{DS(on)}$ - On-Resistance (Ω)

 $I_D = 9.1 \text{ A}$

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Threshold Voltage

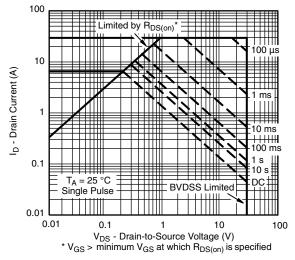


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V_{GS} - Gate-to-Source Voltage (V)

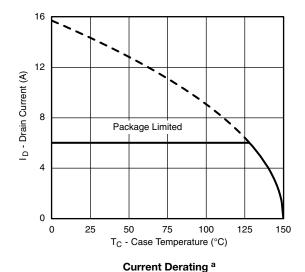
Single Pulse Power

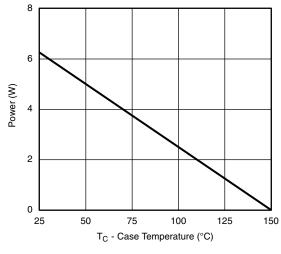


Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





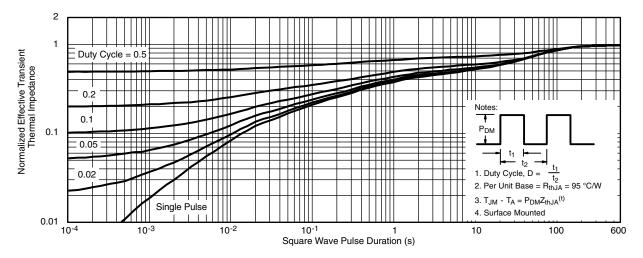
Power Derating

Note

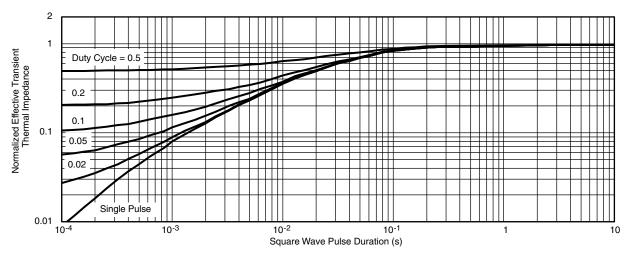
a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



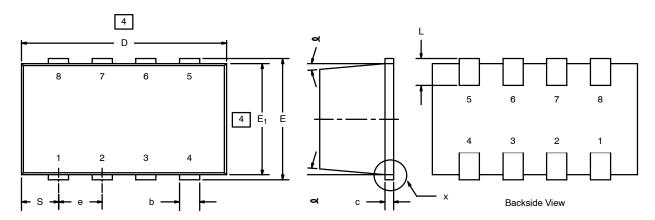
Normalized Thermal Transient Impedance, Junction-to-Ambient

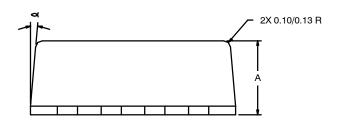


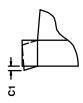
Normalized Thermal Transient Impedance, Junction-to-Foot



DFN 3x2







DETAIL X

NOTES:

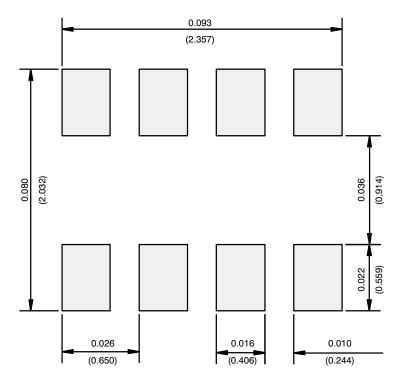
- 1. All dimensions are in millimeaters.
- 2. Mold gate burrs shall not exceed 0.13 mm per side.
- Leadframe to molded body offset is horizontal and vertical shall not exceed 0.08 mm.
- 4. Dimensions exclusive of mold gate burrs.
- 5. No mold flash allowed on the top and bottom lead surface.

	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	1.00	-	1.10	0.039		0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.1	0.15	0.20	0.004	0.006	0.008	
с1	0	-	0.038	0	-	0.0015	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	1.825	1.90	1.975	0.072	0.075	0.078	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.0256 BSC			
L	0.28	-	0.42	0.011	-	0.017	
S	0.55 BSC			0.022 BSC			
4	5°Nom			5°Nom			
ECN: C-03528—Rev. F, 19-Jan-04 DWG: 5547							

DWG: 5547



RECOMMENDED MINIMUM PADS FOR DFN3x2



Recommended Minimum Pads Dimensions in Inches/(mm)



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